Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/734,198	LIN ET AL.	
Examiner	Art Unit	
Adeel Haroon	2618	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	137	4/10/2006	At W
	138	4/10/2006	ALL LINE
	140	4/10/2006	M

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

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	DATE	EXMR
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EAST	4/11/2006	AH